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## ABSTRACT

Selecting the appropriate power switch, typically a MOSFET, is critical for the performance, efficiency, and reliability of a boost converter. An improper selection can lead to poor efficiency and even failures such as shoot-through. This application note provides basic guidelines that aim to aid engineers in the power MOSFET selection. The impact of different MOSFET parameters on converter operation and introduce a dedicated calculation tool is explained. A case study demonstrates the application of these selection guidelines and the calculation tool.

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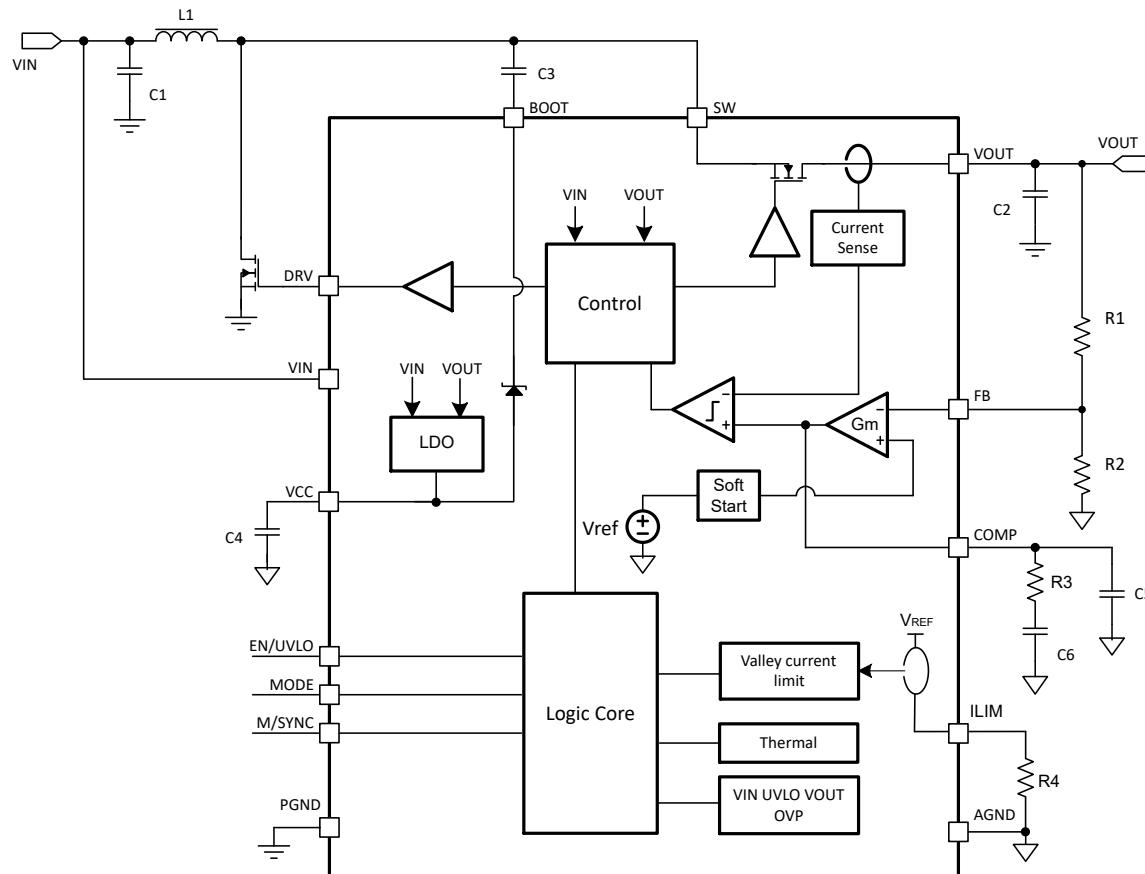
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## 1 Introduction

The TPS61287 is a high-power density, synchronous boost converter that integrates the high side synchronous rectifier MOSFET and uses an external low side MOSFET to provide a high efficiency and small size design. The TPS61287 has a wide input voltage range from 2V to 23V and the output voltage covers up to 25V with 20A switching valley current capability. The TPS61287 uses an adaptive constant on-time valley current control topology to regulate the output voltage. Under moderate to heavy load condition, the TPS61287 operates in pulse width modulation (PWM) mode. There are two optional modes in light load by configuring the MODE pin: Auto PFM mode to improve light-load efficiency and Forced PWM to avoid audible noise and other problems caused by low switching frequency. The switching frequency in the PWM mode is 320kHz. The TPS61287 provides 27V output overvoltage protection, cycle-by-cycle overcurrent protection, and thermal shutdown protection.



**Figure 1-1. TPS61287 Functional Block Diagram**

This application note is a guide for the selection of the external MOSFETs used in combination with the boost device TPS61287.

## 2 Key Parameters for Power MOSFET Selection

### 2.1 Static Characteristics

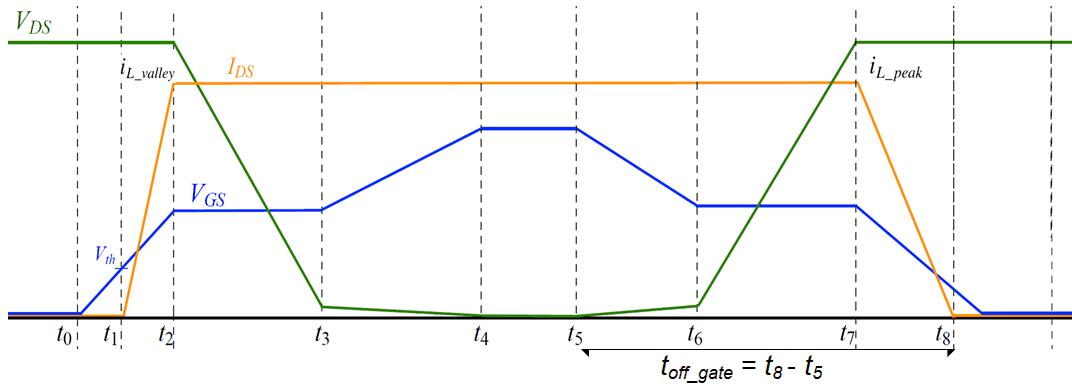
Static parameters usually define the absolute maximum ratings and on-state performance of the switch.

- Drain-Source Voltage ( $V_{DSS}$ ): This must be rated higher than the maximum voltage seen by the MOSFET. For a boost converter, this is at least the maximum output voltage ( $V_{OUT}$ ). A safety margin of 30-50% is recommended to account for voltage spikes caused by parasitic inductance.
- Continuous Drain Current ( $I_D$ ): The MOSFET must handle the RMS and average input current. The RMS current in a boost converter is approximately equal to the input current ( $I_{IN}$ ).
- On-Resistance ( $R_{DS(on)}$ ): This parameter directly determines the conduction losses ( $P_{cond} = I_{RMS}^2 \times R_{DS(on)}$ ). A lower  $R_{DS(on)}$  is desirable but often trades off with higher gate charge.
- Gate threshold voltage ( $V_{GS(th)}$ ) and gate plateau voltage ( $V_{plateau}$ ) or miller voltage ( $V_{miller}$ ): these two voltages must be smaller than the MOSFET gate driving voltage so that the MOSFET can be fully turned on.

### 2.2 Dynamic Characteristics

Dynamic parameters are related to the switching speed and the energy required to gate driver.

The intrinsic capacitances of a MOSFET ( $C_{iss}$ ,  $C_{oss}$ ,  $C_{rss}$ ) decide the switching behavior. [Figure 2-1](#) shows the switching process of a usual Boost device low-side MOSFET and then the role of these capacitances is explained.



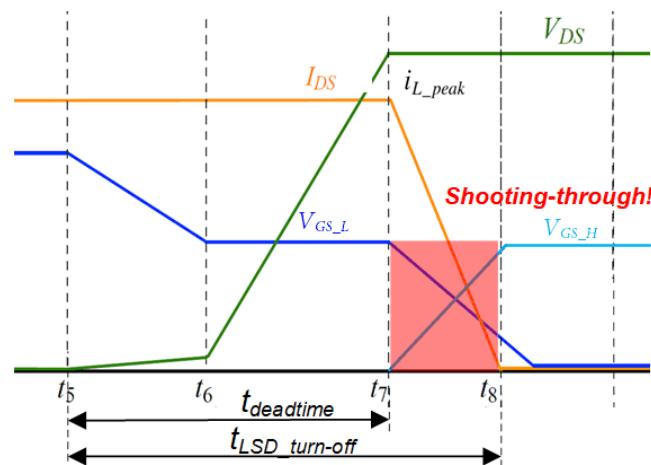
**Figure 2-1. MOSFET Switching Waveforms**

How capacitances affect switching speed: when the MOSFET is turning on, the gate driver must charge  $C_{iss}$  (input capacitance) to turn the MOSFET on first (from  $t_0$  to  $t_2$ ). As  $V_{GS}$  reaches the plateau voltage, the driver current is consumed to discharge  $C_{rss}$ , which falls down the  $V_{DS}$  (from  $t_2$  to  $t_3$ ). A larger total gate charge ( $Q_g$ ) and capacitance require more drive current and time to switch.

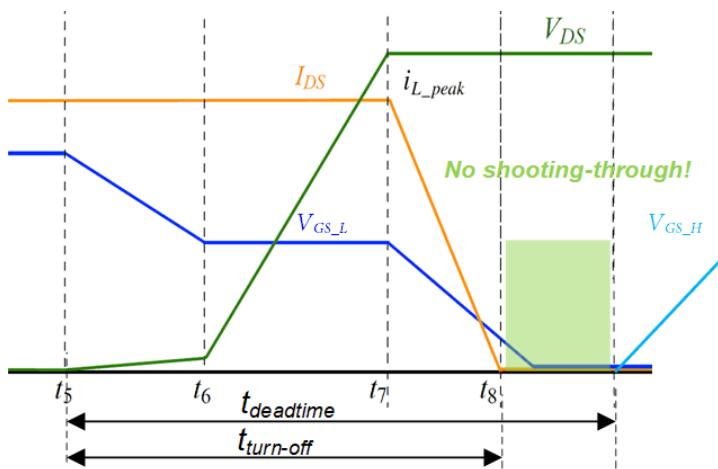
Usually there are two negative impacts with larger capacitance:

1. Increased switching losses: slower switching transitions increase the time during which high voltage and high current overlap ( $t_1$  to  $t_3$  and  $t_6$  to  $t_8$  in [Figure 2-1](#)), leading to high switching losses ( $P_{sw}$ ) and low efficiency.
2. Risk of shoot-through: if the switch turns off too slowly, there is not enough time to prevent both the high-side and low-side switches from being on simultaneously. This shoot-through condition creates a short circuit across the output voltage rail, and there is a high risk of destroying the MOSFET and the Boost controller.

For controllers with adjustable dead time, the dead time must be set longer than the sum of the turn-off delay of the switch and fall time to avoid shooting-through. While for controllers with fixed dead time like TPS61287, the selected MOSFET must have a sufficiently low  $Q_g$  or junction capacitance to verify the switching time is shorter than the fixed dead time.



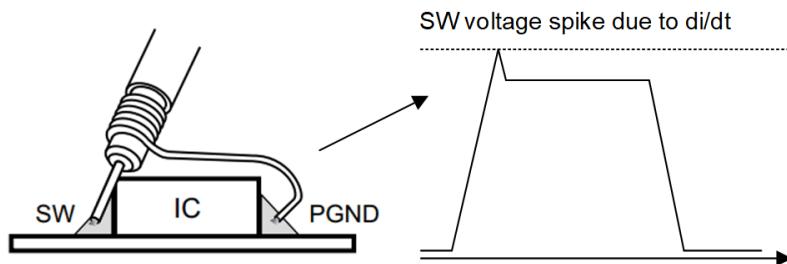
**Figure 2-2. Switching Behavior with Poor Dynamic Characteristic**



**Figure 2-3. Switching Behavior with Good Dynamic Characteristics**

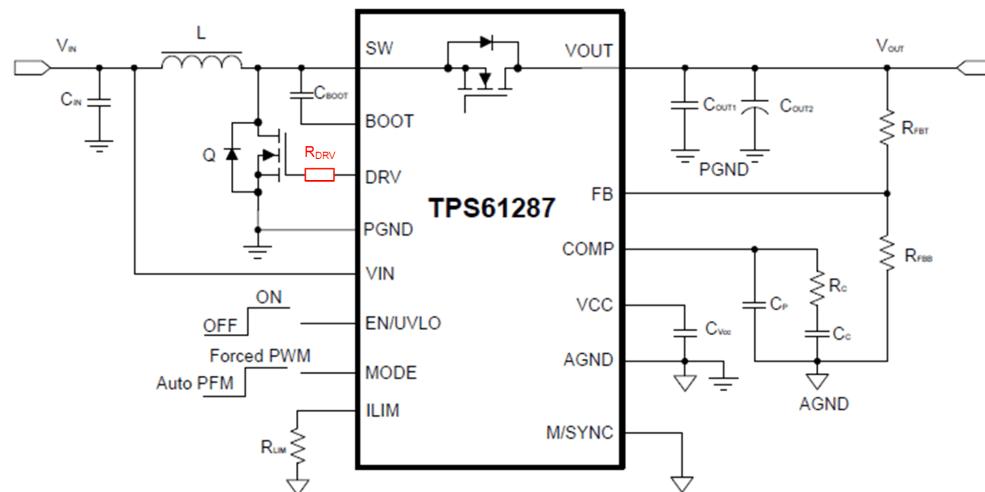
Figure 2-2 and Figure 2-3 clearly demonstrates the negative impact of high dynamic parameters on switching speed and the risk of shooting-through.

However, the MOSFET junction capacitance is not as small as possible. Too small a junction capacitance can cause the switching speed to be too fast, increasing the SW voltage spikes (transient voltage at nanosecond level), causing the MOSFET and chip overvoltage stress. For safety of TPS61287, TI recommends that engineers control the voltage spike of the SW below 36V.



**Figure 2-4. SW Voltage Spike Measurement with Low-Inductance Probe**

If the SW voltage spike is too high due to the selection of a MOSFET with a very small junction capacitance, TI recommends series a drive resistor (RDRV) at the gate of the MOSFET to slow the drive speed and thus reduce the SW voltage spike.



**Figure 2-5. Gate Drive Resistor to Slow the Drive Speed and Reduce the SW Voltage Spike**

### 2.3 Thermal Parameters

Thermal management verifies the switch operates within the safe operating area (SOA).

- Junction-to-Ambient Thermal Resistance ( $R_{\theta JA}$ ): This defines the temperature rise from the junction to the ambient air for a given power dissipation. A lower  $R_{\theta JA}$  (achieved through better packages or heatsinking) is critical for heat dissipation.
- Total Power Dissipation ( $P_D$ ): The sum of conduction and switching losses. The junction temperature can be calculated as:  $T_J = T_A + (P_D \times R_{\theta JA})$ , where  $T_A$  is the ambient temperature.  $T_J$  must always remain below the maximum rating (typically 150°C or 175°C).

### 3 Introduction to the MOSFET Selection Tool

To simplify the selection process for our TPS61287 boost controller family, an excel-based calculation tool has been developed. Navigate [here](#) to use the calculation tool.

The calculator can also take user inputs about the operating conditions, BOM, and system requirements to estimate power loss and efficiency. Note that the calculator does not consider power loss from other sources such as reverse recovery loss. The efficiency calculator is best used to compare one FET to another FET.

The calculator includes a low-side MOSFET selection section to estimate the turn-off time; the section can be used to select a MOSFET with proper dynamic characteristics.

#### 3.1 Input MOSFET Parameters to Calculation Tool

This section aims to guide engineers on how to get the input parameters in calculation tool to select a proper MOSFET.

First input the application specifications, entering parameters such as  $V_{IN}$ (min/max),  $V_{OUT}$ ,  $I_{OUT}$ , switching frequency and the LC parameters. Then choose a candidate MOSFET and manually enter the key parameters as shown in [Figure 3-1](#).

Step 7: Low-Side MOSFET Selection	
On-State resistance, $R_{DS(on)}$	7 mΩ
Total gate charge, $Q_G$	9 nC
Gate resistance, $R_G$	0.8 Ω
External gate resistance on PCB, $R_{G\_PCB}$	0 Ω
Input capacitance at $V_{ds}=0V$ , $C_{iss\_0V}$	2000 pF
Input capacitance at $V_{ds}=V_{out}$ , $C_{iss\_Vout}$	1800 pF
Output capacitance at $V_{ds}=0V$ , $C_{oss\_0V}$	2200 pF
Output capacitance at $V_{ds}=V_{out}$ , $C_{oss\_Vout}$	500 pF
Reverse transfer capacitance at $V_{ds}=0V$ , $C_{rss\_0V}$	450 pF
Reverse transfer capacitance at $V_{ds}=V_{out}$ , $C_{rss\_Vout}$	40 pF
Low side FET gate driving voltage, $V_{LS\_gate}$	5.1 V
Gate-Source Threshold Voltage, $V_{GS(TH)}$	1.2 V
Gate plateau voltage / miller voltage, $V_{plateau}$	2.5 V
LS-GATE off to HS-GATE on deadtime, $t_{DOL}$	30.0 ns
Calculated low side gate turn off time, $t_{off\_gate}$ (should be smaller than deadtime $t_{DOL}$ )	19.2 ns

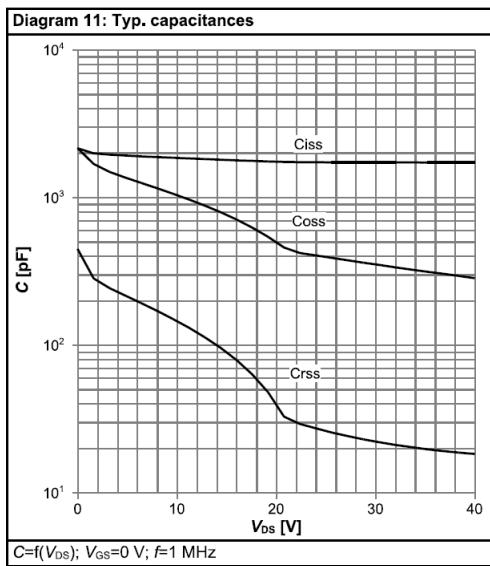
**Figure 3-1. Input MOSFET Parameters in Calculation Tool**

The first parameter in the design calculator is the on-state resistance ( $R_{DS(on)}$ ). The calculator asks for  $R_{DS(on)}$  at 5.1V driving voltage.  $R_{DS(on)}$  is typically given in the data sheet either in the electrical characteristics section or in a graph that plots the  $V_{gs}$  versus  $R_{DS(on)}$ .

The total gate charge ( $Q_G$ ) refers to the charge (in coulombs) necessary to charge the gate capacitance to turn on the MOSFET so that the actual gate voltage of the MOSFET matches the driving voltage. This is different from the switching charge.  $Q_G$  is typically given in the MOSFET data sheet.

The internal gate resistance  $R_G$  can be modeled by a resistor in series with the MOSFET gate, while  $R_{G\_PCB}$  is the external gate resistance introduced by PCB copper trace or external resistor.

The  $C_{iss}$ ,  $C_{rss}$ ,  $C_{oss}$  is the input, reverse and output junction capacitance. Noted that the dynamic characteristic of a MOSFET mainly varies with the drain-source voltage  $V_{DS}$ . [Figure 3-2](#) shows the dependency of  $C_{iss}$ ,  $C_{rss}$ ,  $C_{oss}$  on  $V_{DS}$ . The junction capacitance is typically given in a graph that plots the  $V_{DS}$  versus capacitance.



**Figure 3-2. MOSFET  $C_{iss}$ ,  $C_{rss}$ ,  $C_{oss}$  versus  $V_{DS}$**

The gate-source threshold voltage  $V_{GSTH}$ , is the threshold voltage that the MOSFET is turned on, while the gate plateau voltage or miller voltage is the voltage that the  $C_{rss}$  is charged. These two voltages are typically given in the MOSFET data sheet.

### 3.2 Review the Results

The tool automatically calculates:

- The recommended BOM for provided conditions.
- A warning if the estimated low side turn-off time approaches the fixed dead time of the controller.
- The estimated bold plot, phase margin and gain margin to evaluate stability.
- The estimated low-side MOSFET power loss, total power dissipation, predicted junction temperature and efficiency.

Note that the results in the tool are the calculation results by theory; this does not consider some impact from non-linear circuits and components. The calculation tool is best used to compare different BOMs or quickly get a starting point for system parameters design.

## 4 Calculator Tool MOSFET Selection Example and Bench Evaluation

This section gives an example of how to use the calculation tool for the design of TPS61287. For this example, the following operating conditions are used.

The other input parameters are left as the default.

**Table 4-1. Operating Conditions for Design Calculator Example**

Parameter	Value	Unit
$V_{IN}$ (minimum)	3.0	V
$V_{IN}$ (nominal)	3.6	V
$V_{IN}$ (maximum)	4.2	V
$V_{OUT}$	18	V
$I_{OUT}$ (maximum)	2	A
$I_{LIM}$	20	A
$T_A$	25	°C

There are two MOSFET candidates, option A and option B, with same  $R_{DS(on)}$  while option A has larger junction capacitance than option B.

After the yellow cell are filled in, the calculator can get the low side MOSFET turn-off time, power loss, temperature rise and total efficiency.

Step 7: Low-Side MOSFET Selection	
On-State resistance, $R_{DS(on)}$	7 mΩ
Total gate charge, $Q_G$	34 nC
Gate resistance, $R_G$	0.9 Ω
External gate resistance on PCB, $R_{G\_PCB}$	0 Ω
Input capacitance at $V_{DS}=0V$ , $C_{iss\_0V}$	5000 pF
Input capacitance at $V_{DS}=V_{OUT}$ , $C_{iss\_Vout}$	3527 pF
Output capacitance at $V_{DS}=0V$ , $C_{oss\_0V}$	2000 pF
Output capacitance at $V_{DS}=V_{OUT}$ , $C_{oss\_Vout}$	257 pF
Reverse transfer capacitance at $V_{DS}=0V$ , $C_{rss\_0V}$	1500 pF
Reverse transfer capacitance at $V_{DS}=V_{OUT}$ , $C_{rss\_Vout}$	215 pF
Low side FET gate driving voltage, $V_{LS\_gate}$	5.1 V
Gate-Source Threshold Voltage, $V_{GS(th)}$	2 V
Gate plateau voltage / miller voltage, $V_{plateau}$	3 V
LS-GATE off to HS-GATE on deadtime, $t_{DHS}$	30.0 ns
Calculated low side gate turn off time, $t_{off\_gate}$ (should be smaller than deadtime $t_{DHS}$ )	34.3 ns

Step 8: Efficiency Analyzer	
Default EVM Inductor DC loss, $P_{loss\_inductor\_DC}$	931 mW
Actually used inductor DC loss, $P_{loss\_act\_inductor\_DC}$	0 mW
Default EVM Inductor AC loss, $P_{loss\_inductor\_AC}$	59 mW
Actually used inductor AC loss, $P_{loss\_act\_inductor\_AC}$	0 mW
Low-side MOSFET power loss, $P_{loss\_LS\_FET}$	1746 mW
IC power loss, $P_{loss\_IC}$	1631 mW
Low-side MOSFET Junction-to-ambient thermal resistance, $R_{JIA\_FET}$	53 °C/W
Low-side MOSFET junction temperature rise	92.5 °C
IC Junction-to-ambient thermal resistance, $R_{JIA\_IC}$	36.6 °C/W
IC junction temperature rise	59.7 °C
Calculated efficiency on PWM@ $V_{IN\_nom}$ , $V_{OUT}$ , $I_{OUT\_MAX}$ , $f_{SW}$	89.2 %

**Figure 4-1. Option A Calculated Results**

Step 7: Low-Side MOSFET Selection	
On-State resistance, $R_{DS(on)}$	7 mΩ
Total gate charge, $Q_g$	9 nC
Gate resistance, $R_g$	0.8 Ω
External gate resistance on PCB, $R_{g\_PCB}$	0 Ω
Input capacitance at $V_{ds}=0V$ , $C_{iss\_0V}$	2000 pF
Input capacitance at $V_{ds}=V_{out}$ , $C_{iss\_Vout}$	1800 pF
Output capacitance at $V_{ds}=0V$ , $C_{oss\_0V}$	2200 pF
Output capacitance at $V_{ds}=V_{out}$ , $C_{oss\_Vout}$	500 pF
Reverse transfer capacitance at $V_{ds}=0V$ , $C_{rss\_0V}$	450 pF
Reverse transfer capacitance at $V_{ds}=V_{out}$ , $C_{rss\_Vout}$	40 pF
Low side FET gate driving voltage, $V_{IS\_gate}$	5.1 V
Gate-Source Threshold Voltage, $V_{GS(th)}$	1.2 V
Gate plateau voltage / miller voltage, $V_{plateau}$	2.5 V
LS-GATE off to HS-GATE on deadtime, $t_{DOL}$	30.0 ns
Calculated low side gate turn off time, $t_{off\_gate}$ (should be smaller than deadtime $t_{DOL}$ )	19.2 ns

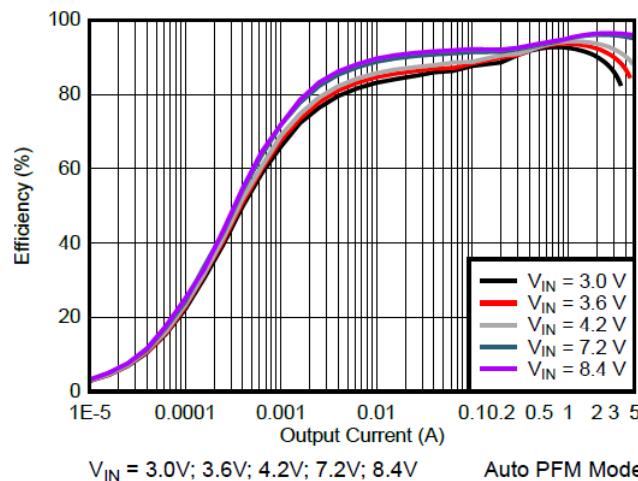
Step 8: Efficiency Analyzer	
Default EVM Inductor DC loss, $P_{loss\_inductor\_DC}$	931 mW
Actually used inductor DC loss, $P_{loss\_act\_inductor\_DC}$	59 mW
Default EVM Inductor AC loss, $P_{loss\_inductor\_AC}$	59 mW
Actually used inductor AC loss, $P_{loss\_act\_inductor\_AC}$	59 mW
Low-side MOSFET power loss, $P_{loss\_IS\_FET}$	1023 mW
IC power loss, $P_{loss\_IC}$	1383 mW
Low-side MOSFET Junction-to-ambient thermal resistance, $R_{JIA\_FET}$	60 °C/W
Low-side MOSFET junction temperature rise	61.4 °C
IC Junction-to-ambient thermal resistance, $R_{JIA\_IC}$	36.6 °C/W
IC junction temperature rise	50.6 °C
Calculated efficiency on PWM@ $V_{IN\_nom}$ , $V_{OUT}$ , $I_{OUT\_MAX}$ , $f_{SW}$	91.4 %

**Figure 4-2. Option B Calculated Results**

Option A has worse dynamic characteristics than option B, which led to significantly higher power loss (1746mW with option A while 1023mW with option B), higher temperature (92.5°C with option A while 61.4°C with option B) and poorer efficiency (89.2% with option A while 91.4% with option B).

More importantly, the turn-off time of option A is calculated as 34.3ns, which is longer than the LS-GATE off to HS-GATE on deadtime (30ns). A warning is listed here considering the risk of shoot-through. The turn-off time is 19.2ns with option B, which is much shorter than deadtime.

So, option B was chosen as option B provided lower power loss, meeting both the dynamic performance and thermal requirements. [Figure 4-3](#) shows the efficiency curve on bench with the option B MOSFET.



**Figure 4-3. Efficiency Curve of TPS61287 With Option B MOSFET**

## 5 Summary

TPS61287 device can be used to create efficient Boost converter systems for many kinds of applications. The efficiency of these systems can vary based on the operating conditions of the system and BOM selection, especially the MOSFET selection. The data sheet parameters of the MOSFET need to be reviewed and considered carefully. Engineers must verify the voltage of the MOSFET and current ratings exceed the application requirements with sufficient margin. Crucially, the dynamic parameters, particularly gate charge and capacitances, must be compatible with the gate drive strength of the controller and dead time to minimize switching losses and prevent shoot-through. Thermal calculations are mandatory to validate the reliability of the design. Utilizing the calculation tool for our TPS61287 devices streamlines this process, enabling a swift and preferred MOSFET choice, leading to efficient and robust boost designs.

## 6 References

1. Texas Instruments, [\*TPS61287 23V VIN, 25V VOUT 20A Synchronous Boost Converter with Stackable Multiphase Function\*](#), datasheet.
2. Texas Instruments, [\*MOSFET Selection Guide for BQ2575x Family\*](#), application note.
3. Texas Instruments, [\*MOSFET Support and Training Tools\*](#), application note.
4. Texas Instruments, [\*Understanding the Absolute Maximum Ratings of the SW Node\*](#), application note.

## 7 Revision History

### Changes from Revision \* (January 2026) to Revision A (February 2026)

	Page
• Added link to calculation tool.....	6
• Updated the numbering format for tables, figures, and cross-references throughout the document.....	6

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